

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10516818	TANAKA ET AL.
Examiner	Art Unit	
David M Naff	1657	

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
West-see search history	8/1/08	DMN
West-see search history	1/19/09	DMN

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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